

**Search Notes**

Application/Control No.

10/697,402

Examiner

Anthony Weier

Applicant(s)/Patent under  
Reexamination

AKASHE ET AL.

Art Unit

1761

**SEARCHED**

Class	Subclass	Date	Examiner
updated	previous search and		
426	657	5/3/2006	AW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
426	657, 495		
	422, 583	5/3/2006	AW

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PGPubl Text Search	5/3/2006	AW